

Search Notes

Application/Control No.

10/526,492

Examiner

Richard Chan

Applicant(s)/Patent under
Reexamination

EDER ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
381	317	9/7/2006	RC
381	312	9/7/2006	RC
455	130	9/7/2006	RC
455	227	9/7/2006	RC
375	316	9/7/2006	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Please See EAST search	3/18/2007	